

FCC TEST REPORT

Guilin Zhishen Information Technology Co., Ltd. **APPLICANT**

Digital Camera Stabilizer PRODUCT NAME

MODEL NAME Shining

TRADE NAME N/A

BRAND NAME

FCC ID 2AIHFZYSL

STANDARD(S) : 47 CFR Part 15 Subpart B

TEST DATE 2016-06-28 to 2016-07-15

ISSUE DATE 2016-07-20

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.

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DIRECTORY

<u>1.</u>	TECHNICAL	INFORMATION					<u>5</u>
1.1.	APPLICANT	INFORMATION					5
		UNDER TEST (EUT)					
		MORE ME					
2.	TEST RESU	LTS					6
RLA	MORL	ME	RLAL	MORE	III.	B CRL	AL MOR
2 .1.	APPLIED RE	EFERENCE DOCUMEN	ITS				6
3.	TEST COND	ITIONS SETTING					7
3.1.	TEST MODE						7
3.2.	TEST SETU	P AND EQUIPMENTS L	_IST				8
3.2.	1. CONDUCT	TED EMISSION	<u>Pr</u>				8
		EMISSION					
4.	47 CFR PAR	T 15B REQUIREM	ENTS				11
4.1.	CONDUCTE	D EMISSION					11
		MENT					
4.1.	2. TEST DES	SCRIPTION					11
		SULT					
		EMISSION					
		MENT					
		SCRIPTION					
		ICY RANGE OF MEASU					
4.2.	4. TEST RES	SULT					15
<u>ANI</u>	NEX A TES	T UNCERTAINTY	<u> </u>				18
<u> </u>	NEX B TES	TING LABORATOR	RY INFORMATION	ON			19
aLA!	ORLA						
1.	IDENTIFICAT	TION OF THE RESPON	SIBLE TESTING L	_ABORATORY		•••••	19



3.	ACCREDITATION CERTIFICATE	
4.	TEST ENVIRONMENT CONDITIONS19	

	Change History				
Issue	Issue Date Reason for change				
1.0	2016-07-20	First edition			



Test Report Declaration

Applicant	Guilin Zhishen Information Technology Co.,Ltd.	
Applicant Address	6F,Bldg 13,Creative Industrial Park,Guimo Road	
Manufacturer	Guilin Zhishen Information Technology Co.,Ltd.	
Manufacturer Address	6F,Bldg 13,Creative Industrial Park,Guimo Road	
Product Name	Digital Camera Stabilizer	
Model Name	Shining	
Brand Name	₹	
HW Version	V1.0	
SW Version	V1.0	
Test Standards	47 CFR Part 15 Subpart B	
Test Result	PASS	

Tested by Peng Shiqing(Test Engineer)

Xì AO Xì ONG Xiao Xiong (EMC Manager) Reviewed by

Zeng Dexin Zeng Dexin (Chief Engineer) Approved by



1. Technical Information

Note: Provided by applicant

1.1. Applicant Information

Company: Guilin Zhishen Information Technology Co.,Ltd.
Address: 6F,Bldg 13,Creative Industrial Park, Guimo Road

1.2. Equipment under Test (EUT) Description

EUT Type:	Digital Camera Stabilizer		
Serial No:	(N/A, marked #1 by test site)		
Hardware Version:	V1.0		
Software Version:	V1.0		
Rated Voltage:	14.8V		
Rated Current:	300mA		

Power Supply :	Battery	JE W. STUBE TOKEN MON JE W.
ALL HOW ORLAS IN	Brand Name:	The state of the s
MORE TAR	Model No.:	18650 锂电池
ORLA	Serial No.:	(N/A ,marked #1 by test site)
E ME SLAE OF	Capacity:	2000mAh
RLA MORE B MC	Rated Voltage:	3.7V
LAE ORLAN	Charge Limit:	4.20V±0.05 V

NOTE:

- The EUT supports ISM 2.4GHz Bluetooth band. It is equipped with a Micro-B USB port which
 can be connected to the ancillary.
- 2. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.



2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15(July 12, 2016	Radio Frequency Devices
	Edition)	CLAP TORLY MOY

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Result
121	15.107	Conducted Emission	2016.07.14	PASS
2	15.109	Radiated Emission	2016.07.14	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.



3. Test Conditions Setting

3.1. Test Mode

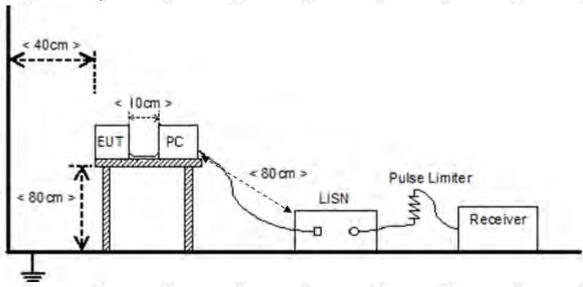
1	The first test mode				
	The EUT configuration of the emission tests is EUT + Battery + PC.				
	During the measurement, the EUT was connected with a PC through the Micro-B USB				
	port, the EUT was kept upgrading software and charging by the PC.				
2	The second test mode				
	The EUT configuration of the emission tests is USB Line + Battery + Charger + PC.				
	During the measurement, battery was put into charger which was connected with a PC				
	through the USB Line, the battery was kept charging by the PC.				
Note: A	Il test modes were performed, only the worse mode(The first test mode) was record in				
the rep	ort. Of the Art Hotel Art Art Art				



3.2. Test Setup and Equipments List

3.2.1. Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

The power strip or extension cord has been investigated to make sure that the LISN integrity in maintained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

B. Equipments List:

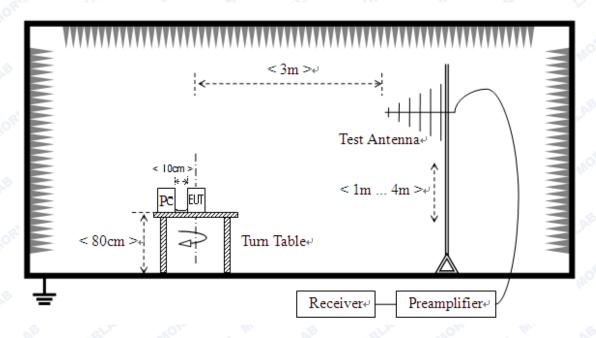
Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
Receiver	Narda	PMM 9010	595WX11007	2016.01.13	2017.01.12
Receiver	Narda	PMM 9060	001WX11001	2015.11.26	2016.11.25
LISN	Schwarzbeck	NSLK 8127	812744	2016.01.13	2017.01.12
Pulse Limiter (20dB)	Schwarzbeck	VTSD 9561-D	9391	2016.01.13	2017.01.12
PC	Apple	A1370	C02FQ2PYD DQW	N/A	N/A



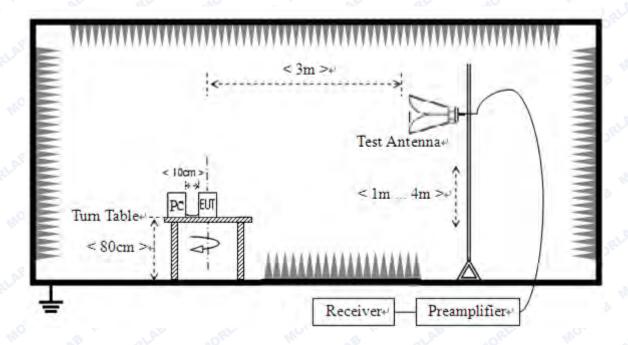
3.2.2. Radiated Emission

A. Test Setup:

For radiated emissions from 30MHz to1GHz



2. For radiated emissions above 1GHz





The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2016.01.13	2017.01.12
Semi-Anechoic Chamber	Albatross	9m*6m*6m	(n.a.)	2016.01.13	2017.01.12
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2016.01.13	2017.01.12
Test Antenna - Horn	Schwarzbeck	BBHA 9120D	9120D-963	2016.01.13	2017.01.12
PC	Apple	A1370	C02FQ2PYDDQW	N/A	N/A



4. 47 CFR Part 15B Requirements

4.1. Conducted Emission

4.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu\text{H}/50\Omega$ line impedance stabilization network (LISN).

Frequency range	Conducted Limit (dBµV)		
(MHz)	Quasi-peak	Average	
0.15 - 0.50	66 to 56	56 to 46	
0.50 - 5	56	46	
5 - 30	60	50	

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

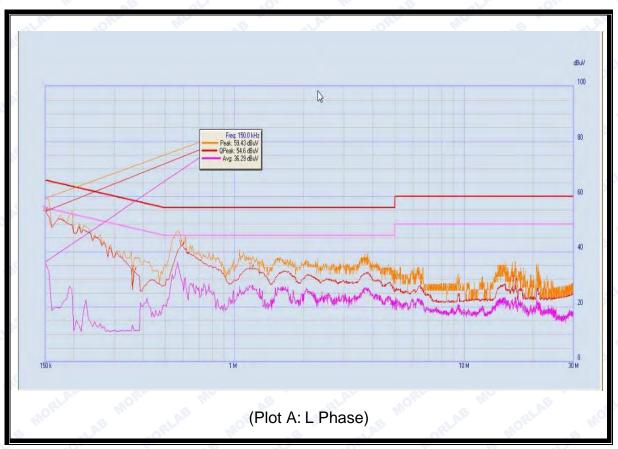
4.1.2. Test Description

See section 3.2.1 of this report.

4.1.3. Test Result

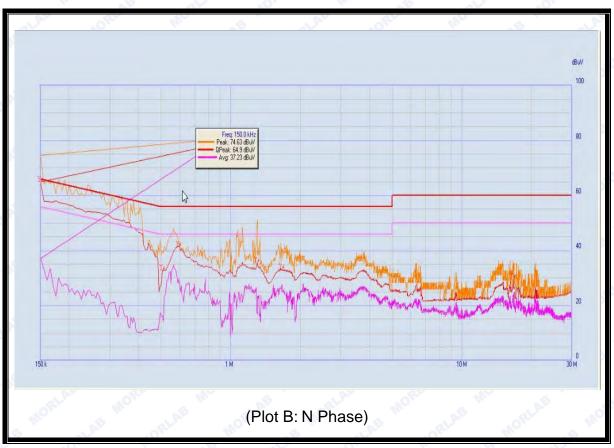
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.





No.	Fre.	Emission Level (dBµV)		Limit (dΒμV)	Power-line	Verdict
	(MHz)	Quai-peak	Average	Quai-peak	Average		70.0.01
1,100	0.15	54.60	36.29	66.00	56.00	ZLAB	PASS
2	0.365	32.96	11.41	59.86	49.86	OF W	PASS
3	0.59	42.19	29.26	56.00	46.00	NO. A. A.	PASS
4	1.185	34.10	27.06	56.00	46.00	Neutral	PASS
5	16.685	28.49	22.01	60.00	50.00	Moke	PASS
6	20.65	23.90	21.69	60.00	50.00	TLAB	PASS





No.	Fre.	Emission Le	vel (dBµV)	Limit (dΒμV)	Power-line	Verdict
110.	(MHz)	Quai-peak	Average	Quai-peak	Average		7010.01
1/10	0.15	64.90	37.23	66.00	56.00	2LAB	PASS
2	0.505	32.81	16.20	56.00	46.00	OL W	PASS
3	0.595	41.47	29.55	56.00	46.00	NORLA	PASS
4	1.30	35.69	16.70	56.00	46.00	- Neutral	PASS
5	1.66	33.33	26.91	56.00	46.00	Mole	PASS
6	16.73	28.88	24.40	60.00	50.00	OLAB .	PASS

Result: Pass



4.2. Radiated Emission

4.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength Limitation at 3m Measurement Dist					
range (MHz)	(μV/m)	(dBµV/m)				
30.0 - 88.0	100	20log 100				
88.0 - 216.0	150	20log 150				
216.0 - 960.0	200	20log 200				
Above 960.0	500	20log 500				

As shown in FCC section 15.35 (b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBμV/m is calculated by 20log Emission Level (μV/m).
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of Ld1 = Ld2 * (d2/d1)².

Example:

F.S Limit at 30m distance is $30\mu\text{V/m}$, then F.S Limitation at 3m distance is adjusted as Ld1 = L1 = $30\mu\text{V/m}$ * $(10)^2$ = 100 * $30\mu\text{V/m}$

4.2.2. Test Description

See section 3.2.2 of this report.



4.2.3. Frequency range of measurement

According to 15.33(b) (1), the frequency range of radiated measurement for the EUT is listed in the following table:

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measure- ment range (MHz)
Below 1.705	30. 1000. 2000. 5000. 5th harmonic of the highest frequency or 40 GHz, whichever is lower.

4.2.4. Test Result

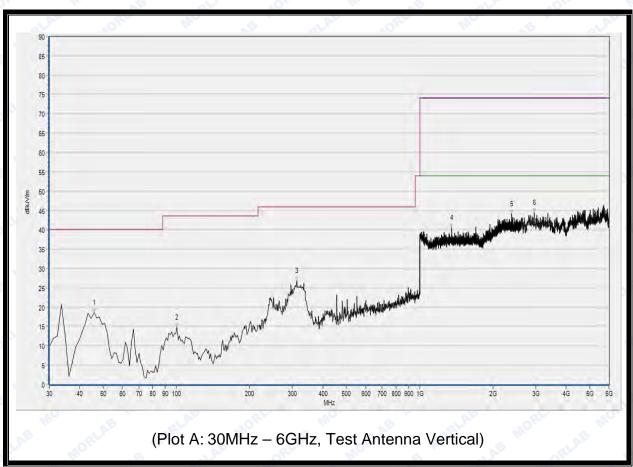
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

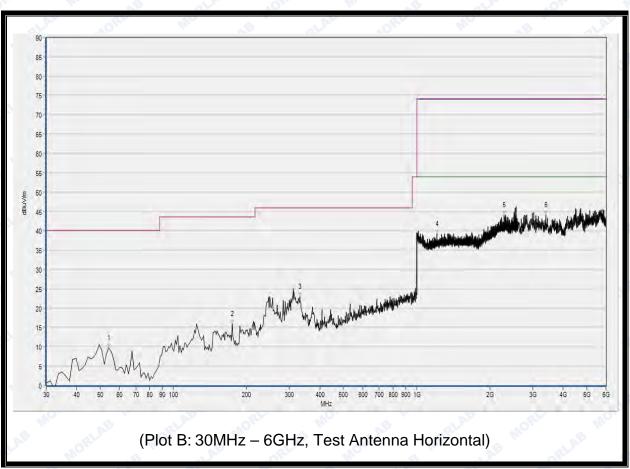
A. Upgrading Software Test Mode:





No.	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANT	Verdict
	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	ZLAB	OPI
1	45.782	N.A.	18.61	N.A.	N.A.	40.00	N.A.	V	PASS
2	100.413	N.A.	14.82	N.A.	N.A.	43.50	N.A.	V	PASS
3	312.866	N.A.	26.88	N.A.	N.A.	46.00	N.A.	V	PASS
4	1352.781	40.58	N.A.	32.65	74.00	N.A.	54.00	V	PASS
5	2388.075	44.00	N.A.	35.99	74.00	N.A.	54.00	V	PASS
6	2966.612	44.43	N.A.	36.12	74.00	N.A.	54.00	V	PASS





No.	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANT	Verdict
	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	CLAB	ORI
1	54.280	N.A.	9.79	N.A.	N.A.	40.00	N.A.	Н	PASS
2	174.468	N.A.	15.96	N.A.	N.A.	43.50	N.A.	Hei	PASS
3	331.076	N.A.	23.04	N.A.	N.A.	46.00	N.A.	H	PASS
4	1210.004	39.16	N.A.	32.44	74.00	N.A.	54.00	Н	PASS
5	2283.073	44.07	N.A.	37.12	74.00	N.A.	54.00	H	PASS
6	3398.400	44.03	N.A.	36.48	74.00	N.A.	54.00	Н	PASS

Result: Pass



Annex A Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Ī	Uncertainty of Conducted Emission:	±1.8dB
Ī	Uncertainty of Radiated Emission:	±3.1dB



Annex B <u>Testing Laboratory Information</u>

1. Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Department:	Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China
Responsible Test Lab Manager:	Mr. Su Feng
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang
	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory: The FCC registration number is 695796.

(Shenzhen Morlab Communications Technology Co., Ltd.)

4. Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

